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2	4	((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) same (density or intensity or lightness or brightness or illumination or (pixel near3 value))) and (vector same tangent same (substitut\$3 or replace\$4 or exchange or chang\$4 or alternat\$3))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 15:16
3	5	((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) and (vector same tangent same (substitut\$3 or replace\$4 or exchange or chang\$4 or alternat\$3))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 15:25
4	412	(vector same tangent same (substitut\$3 or replace\$4 or exchange or chang\$4 or alternat\$3))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 15:26
5	6987	382/103,118,173,176,181,199,190,201,203,282 348/135,136.ccls.	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 15:27
6	6	((vector same tangent same (substitut\$3 or replace\$4 or exchange or chang\$4 or alternat\$3))) and (382/103,118,173,176,181,199,190,201,203,282 DERWENTccls.)	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 15:27
9	2	348#435#93#.PNls.)	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 17:28
10	2	("6335985").PN.	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 17:29
11	2	("5247583").PN.	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 17:29
-	2	("20020025073").PN.	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/25 17:27
-	6030	382/103,173,176,181,199,190,201,203,291.cc1	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/24 15:55
-	54	((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) same (density)) and angle	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/24 15:51
-	7	382/103,173,176,181,199,190,201,203,291.cc1 and (((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) same (density)) and angle)	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/08/24 10:51

-	13	((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) same (density or intensity or lightness or brightness or illumination or (pixel near3 value))) and (angle same (position or coordinate) same vector same direction)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/08/24 15:54
-	120	((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) same (density or intensity or lightness or brightness or illumination or (pixel near3 value))) and (angle and (position or coordinate) and vector and direction)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/08/25 15:02
-	6987	382/103,118,173,176,181,199,190,201,203,282 USPATccls. 348/135,136.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/08/25 15:27
-	33	((((object or target or picture or item) near6 (identif\$7 or determin\$4 or extract\$3 or differentiat\$3 or locat\$3) near6 (background)) same (density or intensity or lightness or brightness or illumination or (pixel near3 value))) and (angle and (position or coordinate) and vector and direction)) and (382/103,118,173,176,181,199,190,201,203,282,291.cccls. 348/135,136.cccls.)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/08/24 15:55


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1 Normal vector identification and interactive tradeoff analysis using minimax formulation in multiobjective optimization

Jian-Bo Yang; Duan Li;
 Systems, Man and Cybernetics, Part A, IEEE Transactions on , Volume: 32 , Issue: 3 , May 2002
 Pages:305 - 319

[\[Abstract\]](#) [\[PDF Full-Text \(1048 KB\)\]](#) [IEEE JNL](#)
2 On the electromagnetic field in a cavity fed by a tangential electric field in an aperture in its wall

Mautz, J.R.;
 Microwave Theory and Techniques, IEEE Transactions on , Volume: 43 , Issue: 3 , March 1995
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[\[Abstract\]](#) [\[PDF Full-Text \(516 KB\)\]](#) [IEEE JNL](#)
3 Planning and control of robot orientational path

Wu, C.H.; Jou, C.C.;
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 Pages:1234 - 1241

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4 Variant of the equations spatial curvilinear rods at the large displacements

Pustovoy, N.V.; Levin, V.E.;
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Power Engineering Society General Meeting, 2003, IEEE , Volume: 4 , 13-17 J 2003
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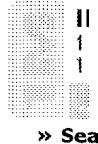
9 Streamline modeling based on potential flow

Suzuki, Y.; Miura, K.T.; Tanaka, I.; Masuda, H.;
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10 A new 60 GHz open resonator method for precision permittivity and tangent measurement

Afsar, M.N.; Hanyi Ding; Weiyu Hua; Tourshan, K.;
Precision Electromagnetic Measurements Digest, 1998 Conference on , 6-10 J 1998
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